Notice of References Cited Application/Control No. 10/748,082 Examiner Thuy V. Tran Applicant(s)/Patent Under Reexamination SAEDI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0036303 A1	02-2003	Fang et al.	439/487
*	В	US-2002/0121094 A1	09-2002	VanHoudt, Paulus Joseph	62/3.3
*	С	US-6,837,059 B2	01-2005	Ueki et al.	62/3.7
*	D	US-6,522,459 B1	02-2003	Pease et al.	359/341.4
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	I	US-			
	J	US-			
	K	US-			_
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	O					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.